20th edition of the Young Belgian Magnetic Resonance Scientists symposium - YBMRS 2024



Contribution ID: 3

Type: Oral contribution

Electrical detection of magnetic resonance on a Chip (EDMRoC): A low-cost and sensitive characterization tool for defects in SiC MOSFETs

Tuesday, 26 November 2024 09:50 (20 minutes)

Field

Other

Primary author: VANDEVENNE, Ilias (University of Antwerp)

Presenter: VANDEVENNE, Ilias (University of Antwerp)

Session Classification: Oral contributions